

Search Notes

Application/Control No.

10/566,910

Examiner

Randall Chin

Applicant(s)/Patent under
Reexamination

KRESSE ET AL.

Art Unit

1744

SEARCHED

Class	Subclass	Date	Examiner
15	228	↓	↓
15	229.4	↓	↓
15	229.8	6/22/2007	RC

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST, OCR, EPO, JPO, DERWENT	↓	↓
Inventor name search	6/22/2007	RC